Search Notes

Application/Contro	l No.	

Applicant(s)/Patent under Reexamination
LIN, WILLIAM

10/665,156 Examiner

Art Unit

Maikhanh Nguyen

2176

	SEARCHED		
Class	Subclass	Date	Examiner
715	513	3/6/2006	МК
	511,514	3/6/2006	MK
	516,530	3/6/2006	MK
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH I (INCLUDING SEAR)
	DATE	EXMR
Inventor Name Search	3/6/2006	MK
West Search	3/6/2006	мк
NPL (ACM)	3/13/2006	МК
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